

N-Channel 60 V (D-S) MOSFET

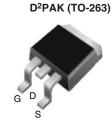
| PRODUCT SUMMARY | | | | | |
|---------------------|----------------------------------|------------------------------------|----------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^{a, e} | Q _g (Max) | | |
| 60 - | 0.023 at V _{GS} = 10 V | 50 | 66 nC | | |
| | 0.027 at V _{GS} = 4.5 V | 40 | 00110 | | |

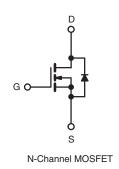
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN FREE





| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | | | | | |
|---|------------------------------------|---|-----------------------------------|------------------|------|--|--|--|--|
| PARAMETER | SYMBOL | LIMIT | UNIT | | | | | | |
| Drain-Source Voltage | | | V _{DS} | 60 | V | | | | |
| Gate-Source Voltage | V _{GS} | ± 10 | v | | | | | | |
| Continuous Drain Current ^f | V _{GS} at 10 V | T _C = 25 °C T _C = 100 °C | - I _D | 50 | | | | | |
| Continuous Drain Current | VGS AL TO V | | | 36 | A | | | | |
| Pulsed Drain Current ^a | | | I _{DM} | 200 | | | | | |
| Linear Derating Factor | | | | 1.0 | W/°C | | | | |
| Linear Derating Factor (PCB Mount) ^e | | 0.025 | W/ C | | | | | | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 400 | mJ | | | | |
| Maximum Power Dissipation $T_{C} = 25 \text{ °C}$ | | 25 °C | P _D | 150 | w | | | | |
| Maximum Power Dissipation (PCB Mount) ^e | int) ^e T _A = | | | 3.7 | vv | | | | |
| Peak Diode Recovery dV/dt ^c | dV/dt | 4.5 | V/ns | | | | | | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 175 | °C | | | | |
| Soldering Recommendations (Peak Temperature) ^d | for | 10 s | | 300 ^d | | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

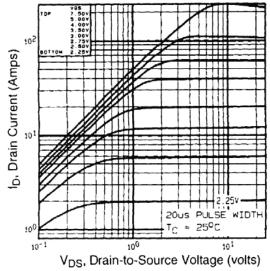
d. 1.6 mm from case.



| THERMAL RESISTANCE RATI | | | | | | | | |
|---|------------------------|---|--------------------------|-----------------------------|------------|-----------------|----------|----------|
| PARAMETER | SYMBOL | TYP. MAX. | | | UNIT | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 62 | | | °C/W | | | |
| Maximum Junction-to-Ambient (PCB Mount) ^a | R _{thJA} | - 40 | | | | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 1.0 | | | | | | |
| lote . When mounted on 1" square PCB (FR-4 o | or G-10 material |). | | | | | | |
| SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u | nless otherw | ise noted) | | | | | | |
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT | |
| Static | | - | | | | • | • | • |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0, I _D = 250 μA | | 60 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference to 25 °C, I _D = 1 mA | | - | 0.070 | - | V/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | | 1.0 | - | 3.0 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{GS} = \pm 10 \text{ V}$ | | - | - | ± 100 | nA | |
| | I _{DSS} | $V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | - | - | 25 | μA | |
| Zero Gate Voltage Drain Current | | V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C | | - | - | 250 | | |
| Drain-Source On-State Resistance | | V _{GS} = 10 V | | = 21 A ^b | - | 23 | - | Ω |
| | R _{DS(on)} | V _{GS} = 4.5 V | | = 15 A ^b | - | 27 | - | |
| Forward Transconductance | g _{fs} | V _{DS} = 25 V, I _D = 21A ^b | | 23 | - | - | S | |
| Dynamic | 010 | | | | 1 | | 1 | |
| Input Capacitance | | | | | | 3000 | - | |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 | | - | 1000 | - | pF | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 200 | - | | |
| Total Gate Charge | Qg | | | | - | 60 | - | <u> </u> |
| Gate-Source Charge | Q _{gs} | $V_{GS} = 5.0 V$ $I_D = 51 A, V_{DS} = 48 V,$ | | | - | 10 | - | nC |
| Gate-Drain Charge | Q _{gd} | | see ng | g. 6 and 13 ^b | - | 40 | - | 1 |
| Turn-On Delay Time | t _{d(on)} | | | - | 17 | - | <u> </u> | |
| Rise Time | t _r | - | = 30 V, I _D = | 51 A | - | 230 | - | ns |
| Turn-Off Delay Time | t _{d(off)} | | | 2, see fig. 10 ^b | - | 42 | - | |
| Fall Time | t _f | | | | - | 110 | - | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH | |
| Internal Source Inductance | Ls | | | - | 7.5 | - | | |
| Drain-Source Body Diode Characteristic | s | • | | | | • | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 50 ^c | A | |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 200 | | |
| Body Diode Voltage | V _{SD} | $T_J = 25 \text{ °C}, I_S = 51 \text{ A}, V_{GS} = 0 \text{ V}^{b}$ | | - | - | 2.5 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | $T_{\rm J} = 25 ^{\circ}\text{C}, I_{\rm F} = 51 \text{A}, \text{dl/dt} = 100 \text{A/}\mu\text{s}^{\rm b}$ | | - | 130 | 180 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.84 | 1.3 | μC | |
| Forward Turn-On Time | t _{on} | Intrinsic tu | rn-on time i | is negligible (turn | -on is dor | ninated b | vlaand | |

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



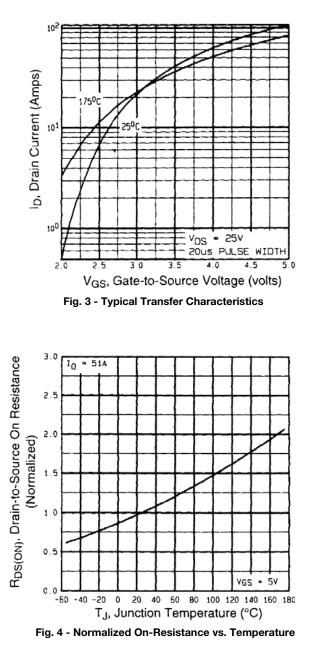


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T_C = 150 °C





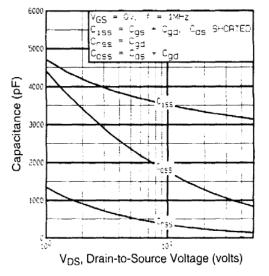


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

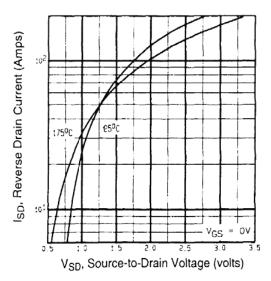


Fig. 7 - Typical Source-Drain Diode Forward Voltage

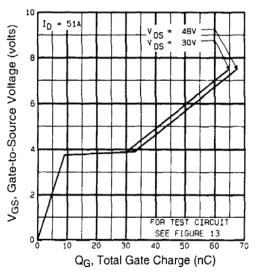
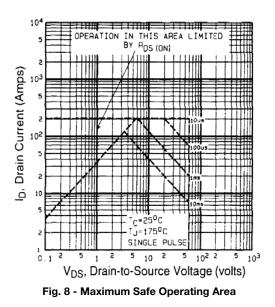


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





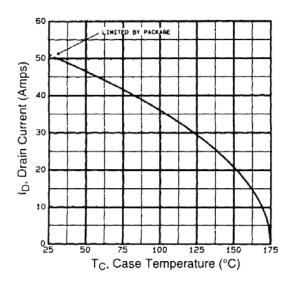


Fig. 9 - Maximum Drain Current vs. Case Temperature

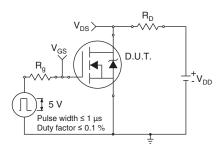


Fig. 10a - Switching Time Test Circuit

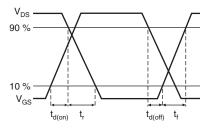


Fig. 10b - Switching Time Waveforms

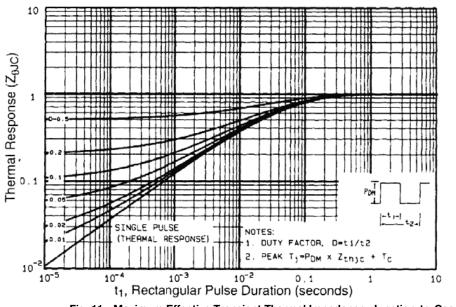


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



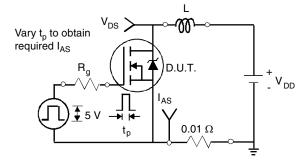


Fig. 12a - Unclamped Inductive Test Circuit

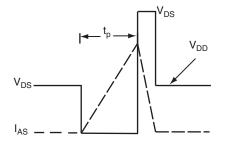


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

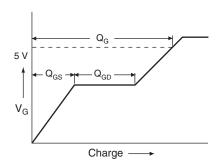


Fig. 13a - Basic Gate Charge Waveform

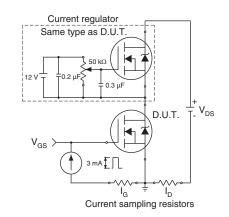
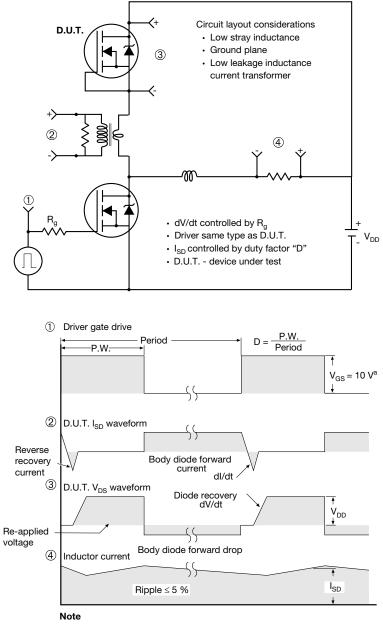


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

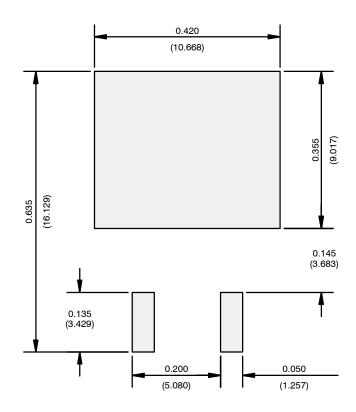


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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